Notice of References Cited

Application/Control No. 09/378,666

Examiner

Applicant(s)/Patent Under Reexamination WATSON ET AL.

Examiner Sang Nguyen Art Unit 2877

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name Classification		ication
	Α	US-5,185,641	02-1993	Igushi et al.	356	336
	В	US-4,595,291	06-1986	Tatsuno	356	336
	С	US-5,428,443	06-1995	Kitamura et al.	356	338
	D	US-				
	Е	US-				
-	F	US-				
	G	US-				
	Н	US-				
	ı	US-				
	J	US-				
	К	US-				
	L	US-				
	М	US-				

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification	
	N	JP 05034259	02-1993	Japan	Niwa		
	0	JP 08178830	07-1996	Japan	Sakata et al.		
	Р						
	Q						
	R						,
	s						
	Т						

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	w					
	×					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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